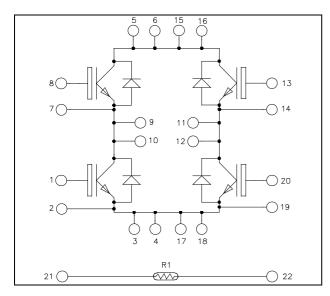


# Full - Bridge NPT IGBT Power Module

$$V_{CES} = 600V$$
  
 $I_C = 50A$  @  $Tc = 80$ °C

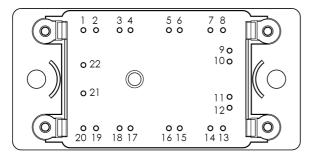


### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

### **Features**

- Non Punch Through (NPT) Fast IGBT
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 100 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- Very low stray inductance
- Internal thermistor for temperature monitoring
- High level of integration



Pins 5/6/15/16; 3/4/17/18; 9/10; 11/12 must be shorted together

#### **Benefits**

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

## All ratings @ $T_j = 25$ °C unless otherwise specified

### Absolute maximum ratings (per IGBT)

Symbol	Parameter		Max ratings	Unit
$V_{CES}$	Collector - Emitter Breakdown Voltage		600	V
$I_{C}$	Continuous Collector Current	$T_C = 25^{\circ}C$	65	
1 <sub>C</sub>	Continuous Conector Current	$T_C = 80^{\circ}C$	50	Α
$I_{CM}$	Pulsed Collector Current	$T_C = 25^{\circ}C$	230	
$V_{GE}$	Gate – Emitter Voltage		±20	V
$P_{\mathrm{D}}$	Maximum Power Dissipation	$T_C = 25^{\circ}C$	250	W
RBSOA	Reverse Bias Safe Operating Area	$T_j = 125^{\circ}C$	100A @ 500V	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



**Electrical Characteristics** (per IGBT)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
$I_{CES}$	Zero Gate Voltage Collector Current	$V_{GE} = 0V ; V_{CE} = 600V$				250	μΑ
V <sub>CE(sat)</sub>	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25$ °C	1.7	2.0	2.45	V
		$I_C = 50A \qquad T_j = 125^{\circ}C$			2.2		V
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 1 \text{mA}$		4		6	V
$I_{GES}$	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				400	nA

**Dynamic Characteristics** (per IGBT)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
Cies	Input Capacitance	$\begin{aligned} V_{GE} &= 0V \\ V_{CE} &= 25V \\ f &= 1MHz \end{aligned}$			2200		
$C_{oes}$	Output Capacitance				323		pF
$C_{res}$	Reverse Transfer Capacitance				200		
$Q_{g}$	Total gate Charge	$V_{GE} = 15V$			166		
$Q_{ge}$	Gate – Emitter Charge	$V_{Bus} = 300V$			20		nC
$Q_{gc}$	Gate – Collector Charge	$I_C = 50A$			100		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switch	ning (25°C)		40		ns
$T_{\rm r}$	Rise Time	$V_{GE} = 15V$			9		
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 400V$ $I_{\text{C}} = 50A$			120		
$T_{\mathrm{f}}$	Fall Time	$R_G = 2.7\Omega$		12			
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C)			42		
$T_{\rm r}$	Rise Time	$V_{GE} = 15V$			10		
$T_{d(off)}$	Turn-off Delay Time	$I_{\text{Bus}} = 400 \text{ V}$ $I_{\text{C}} = 50 \text{ A}$	$V_{\text{Bus}} = 400V$ $I_{\text{C}} = 50A$		130		ns
$T_{\mathrm{f}}$	Fall Time	$R_G = 2.7\Omega$			21		
Eon	Turn-on Switching Energy	$V_{GE} = 15V$ $V_{Bus} = 400V$ $I_{C} = 50A$ $R_{G} = 2.7\Omega$	$T_j = 125$ °C		0.5		T
$E_{\text{off}}$	Turn-off Switching Energy		$T_j = 125$ °C		1		mJ
$I_{sc}$	Short Circuit data	$V_{GE} \le 15V$ ; $V_{Bus} = 360V$ $t_p \le 10 \mu s$ ; $T_i = 125 ^{\circ}C$			225		A
$R_{thJC}$	Junction to Case Thermal Resistance					0.5	°C/W



Reverse diode ratings and characteristics (per diode)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage			600			V
$I_{RM}$	Maximum Reverse Leakage Current	$V_R=600V$				25	μA
$I_{\mathrm{F}}$	DC Forward Current		$Tc = 80^{\circ}C$		25		A
		$I_F = 25A$ $I_F = 50A$			1.8	2.2	
$V_{\rm F}$	Diode Forward Voltage				2.2		V
		$I_F = 25A$	$T_{j} = 125^{\circ}C$		1.5		
t <sub>rr</sub>	Reverse Recovery Time	$I_n = 25 \Delta$	$T_j = 25^{\circ}C$		30		ns
c <sub>rr</sub>			$T_{j} = 125^{\circ}C$		175		115
Q <sub>rr</sub>	Reverse Recovery Charge	$\frac{V_R - 400V}{\text{di/dt} = 200\text{A/}\mu\text{s}}$	$T_j = 25^{\circ}C$		55		nC
			$T_{j} = 125^{\circ}C$		485		nC
$R_{\text{thJC}}$	Junction to Case Thermal Resistance					1.4	°C/W

**Temperature sensor NTC** 

Symbol	Characteristic	Min	Typ	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		22		kΩ
$\Delta R_{25}/R_{25}$	Resistance tolerance			5	%
$\Delta \mathrm{B/B}$	Beta tolerance			3	70
B <sub>25/100</sub>	$T_{25} = 298.16 \text{ K}$		3980		K

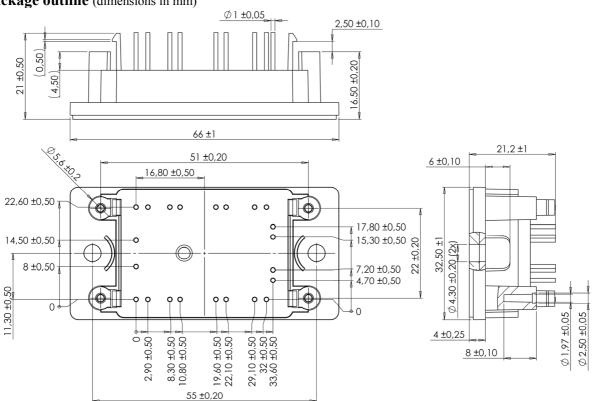
$$R_{T} = \frac{R_{25}}{\exp \left[ B_{25/100} \left( \frac{1}{T_{25}} - \frac{1}{T} \right) \right]}$$
 T: Thermistor temperature R<sub>T</sub>: Thermistor value at T

Thermal and package characteristics

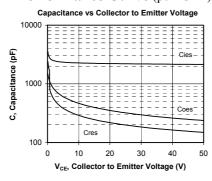
Symbol	Characteristic		Min	Тур	Max	Unit	
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz		4000			V	
$T_{J}$	Operating junction temperature range		-40		150		
$T_{STG}$	Storage Temperature Range		-40		125	°C	
$T_{C}$	Operating Case Temperature			-40		100	
Torque	Mounting torque To heatsink M4		2		3	N.m	
Wt	Package Weight					75	g

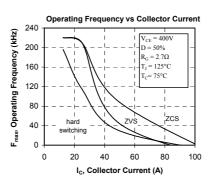


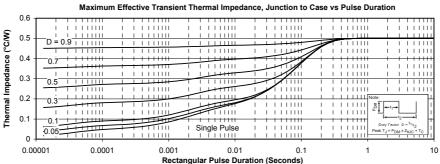
### Package outline (dimensions in mm)



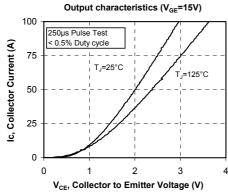
## Typical IGBT Performance Curve (per IGBT)

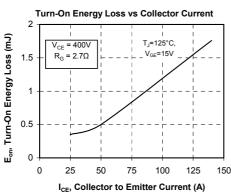


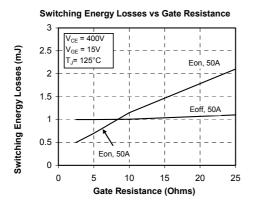


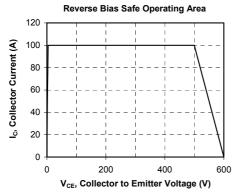


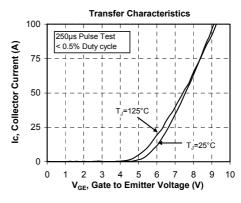


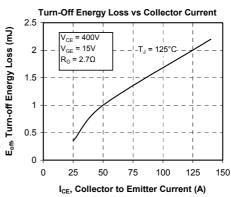


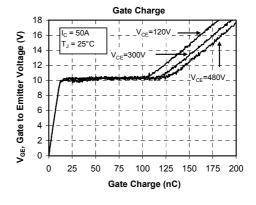






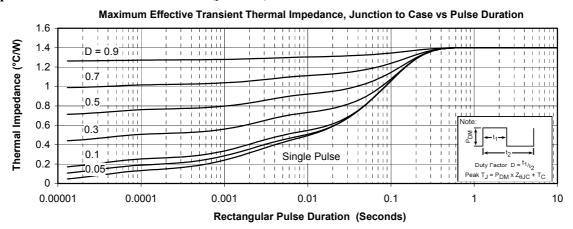


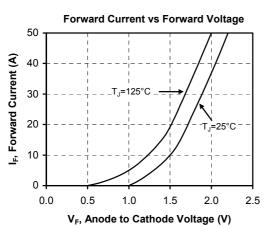






### Typical diode Performance Curve (per diode)





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